

MOSFET - Power, Single N-Channel 60 V, 2.9 mΩ, 139.3 A NVMJS3D0N06C

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	60	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain	Steady State	T _C = 25°C	I _D	139.3	Α
Current R _{θJC} (Notes 1, 3)		T _C = 100°C		98.5	
Power Dissipation		T _C = 25°C	P_{D}	112.5	W
R _{θJC} (Note 1)		T _C = 100°C		56.2	
Continuous Drain		T _A = 25°C	I _D	26.9	Α
Current R _{0JA} (Notes 1, 2, 3)	Steady State	T _A = 100°C		19	
Power Dissipation		T _A = 25°C	P_{D}	4.2	W
R _{θJA} (Notes 1, 2)		T _A = 100°C		2.1	
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	900	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	93.7	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 9.1 A)			E _{AS}	430	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

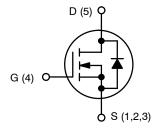
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 1)	$R_{\theta JC}$	1.33	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)	$R_{\theta JA}$	35.9	

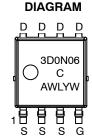
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
60 V	2.9 mΩ @ 10 V	139.3 A



N-CHANNEL MOSFET





MARKING

3D0N06C = Specific Device Code A = Assembly Location

WL = Wafer Lot Y = Year W = Work Week

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				25		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V}, T_{J} = 25^{\circ}\text{C}$				10	
		V _{DS} = 60 V	T _J = 125°C			250	- μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	_S = 20 V			100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= 135 μΑ	2.0		4.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-8.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 27 A		2.2	2.9	mΩ
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				2675		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MH:	z, V _{DS} = 25 V		1920		pF
Reverse Transfer Capacitance	C _{RSS}				21		1
Total Gate Charge	Q _{G(TOT)}				34		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 48 V; I _D = 27 A			7		nC
Gate-to-Source Charge	Q _{GS}				11		
Gate-to-Drain Charge	Q_{GD}				5.5		1
Plateau Voltage	V_{GP}				4.6		V
SWITCHING CHARACTERISTICS (Note 4)						
Turn-On Delay Time	t _{d(ON)}				16		
Rise Time	t _r	V _{GS} = 10 V, V _D	s = 48 V,		6		1
Turn-Off Delay Time	t _{d(OFF)}	V_{GS} = 10 V, V_{DS} = 48 V, I_D = 27 A, R_G = 2.5 Ω			27		ns -
Fall Time	t _f				7		
DRAIN-SOURCE DIODE CHARACTERIS	TICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.8	1.2	V
		I _S = 27 A	T _J = 125°C		0.67		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dls/dt = 100 A/μs, l _S = 27 A			51		
Charge Time	t _a				25		ns
Discharge Time	t _b				26		1
Reverse Recovery Charge	Q _{RR}				36		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

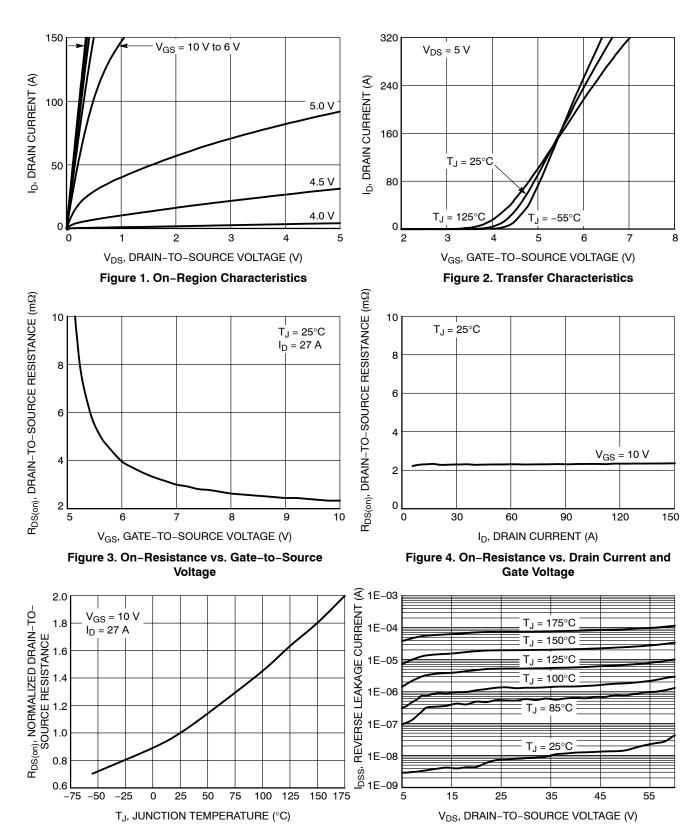


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

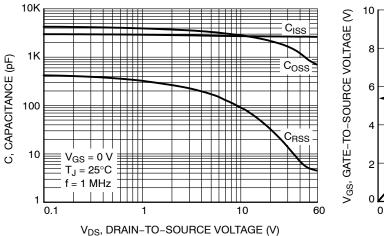


Figure 7. Capacitance Variation

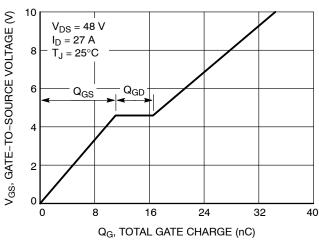


Figure 8. Gate-to-Source vs. Total Charge

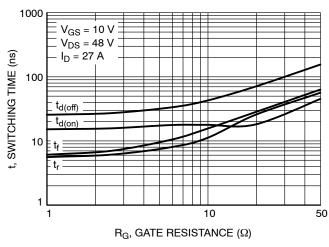


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

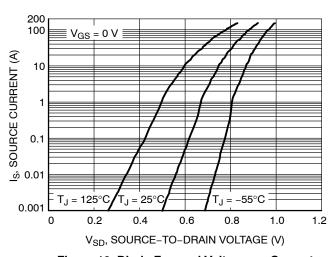


Figure 10. Diode Forward Voltage vs. Current

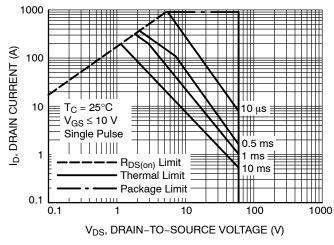


Figure 11. Maximum Rated Forward Biased Safe Operating Area

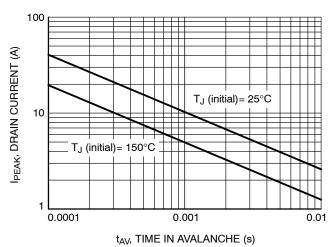


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

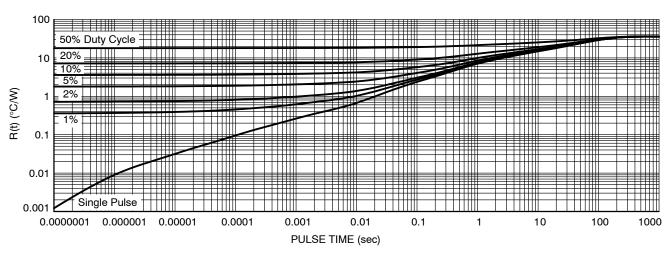


Figure 13. Transient Thermal Impedance

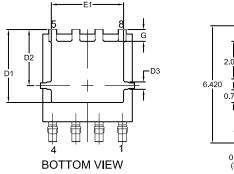
DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMJS3D0N06CTWG	3D0N06C	LFPAK8 (Pb-Free)	3000 / Tape & Reel

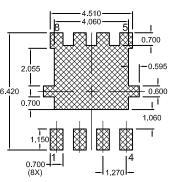
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DETAIL 'A'



△ 0.10 C



RECOMMENDED LAND PAD

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
- 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- 6. OPTIONAL MOLD FEATURE.

MILLIMETERS					
DIM	MIN	NOM	MAX		
Α	1.10	1.20	1.30		
A1	0.00	80.0	0.15		
A2	1.10	1.15	1.20		
A3).25 RE			
A4	0.45	0.50	0.55		
b	0.40	0.45	0.50		
С	0.19	0.22	0.25		
c2	0.19	0.22	0.25		
О	4.70	4.80	4.90		
D1	3.80	4.00	4.20		
D2	3.00	3.10	3.20		
D3	0.30	0.40	0.50		
Е	4.80	4.90	5.00		
E1	3.90	4.00	4.10		
E2	5.00	5.15	5.30		
е		1.27 BSC			
G	0.55	0.65	0.75		
Н	6.00	6.15	6.30		
L	0.45	0.65	0.85		
L1	0.15	0.25	0.35		
L2	0.90	1.10	1.30		
q	0°	4°	8°		

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